Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/733,117	NICKEL-JETTER ET AL.	
Examiner	Art Unit	
Nguyen N. Hanh	2834	

	SEARCHED					
Class	Subclass	Date	Examiner			
310	156.01- 156.84	7/27/2005	HN			
310	67R	7/27/2005	HN			
310	68D	7/27/2005	. HN			
undati	AC	11/25/65	HN			
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310	254	11/25/05	HN			
30	253	11/25/05	NH			
310	259	11/25/05	HN			

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
310	010	11/25/05	HΝ			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consult Daup Le, Primary Examiner for adolytimal search	11/23/05	HN
PG Pub Text search, see interference search Print out.	11/26/05	HN
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